

**Search Notes**

Application/Control No.

10/669,919

Examiner

Y. J. Han

Applicant(s)/Patent under  
Reexamination

STANCU ET AL.

Art Unit

2838

**SEARCHED**

Class	Subclass	Date	Examiner
363	37		
	40		
	41		
	50		
	56.02		
	56.03		
	98		
	132		
	49		
323	908	4/1/2005	JH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
363	41		
	56.02		
	98		
323/908		4/1/2005	JH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR